FORM PTO-1449	TEL OFF	SERIAL NO.		CASE NO.
	TANDEMARK OFF		09/786,818	9683/82
LIST OF PATENT	S AND PUBLICATIONS FOR	FILING DATE		GROUP ART UNIT
APPLICANT'S IN	FORMATION DISCLOSURE		March 9, 2001	To be assigned
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(use several sheets if ne	cessary)	APPLICANT(S	): Youichi Tanibay	vashi et al

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7	A2	5,787,359	07/28/1998	Nagata		
	A3	5,740,539	04/14/1998	Ishii		72
•	A4	5,502,758	03/26/1996	Tsuzuki et al.	4	W TO
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INITIAL		NUMBER	DATE	COUNTRY	SUBCLASS	YES	NO
1	A7	GB 2 322 248 A	08/19/1998	Great Britain			Х
	A8	WO 98/54922 ·	12/03/1998	.WIPO			Х
	A9	JP 2000-4482	01/07/2000	Japan		Х	
	A10	JP 11-351903	12/24/1999	Japan		Х	
	A11	JP 11-178047	07/02/1999	Japan		X	
	A12	JP 11-155025	06/08/1999	Japan		Х	
	A13	JP 11-133135 ,	05/21/1999	Japan		Х	
	A14	JP 11-94923	04/09/1999	Japan		X	
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EXAMINER Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

REFERENCE DESIGNATION

	MAY 0 3 2001			Page 2 of 2
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	2		09/786,818	9683/82
LIST OF PATEN	TS AND PUBLICATIONS OR	FILING DATE		GROUP ART UNIT
APPLICANT'S I	NFORMATION DISCLOSURE STATEMENT		March 9, 2001	To be assigned
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1	$\overline{\varphi}$	A26	JP 9-172672	06/30/1997	Japan		Х	Ţ
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EXAMINER INITIAL	OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)					
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EXAMINER	AL		DATE CONSIDERED	1-28-04	

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FORM PTO-1449	SERIAL NO.	CASE NO.
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LIST OF PATENTS AND BLICATIONS FOR	FILING DATE	GROUP ART UNIT
APPLICANT'S INFORMATION DISCLOSURE	March 9, 2001	2684
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EXAMINER INITIAL				DATE	COUNTRY	CLASS/ SUBCLASS	CONCISE EXPLANATION YES OR NO
	$\mathcal{NP}$	B1	JP10-170625	6/26/1998	Japan		Yes
7	N-P	B2	KR1998-031026	7/25/1998	Korea		Yes
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		В					
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EXAMINER INITIAL		OTHER ART – NON PATENT LITERATURE DOCUMENTS  (Include name of author, title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date page(s), volume-issue number(s), publisher, city and/or country where published.						
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